

**Product Summary**

| $V_{(BR)DSS}$ | $R_{DS(ON)}$ max               | $I_D$ max<br>$T_A = 25^\circ C$ |
|---------------|--------------------------------|---------------------------------|
| 60V           | 40m $\Omega$ @ $V_{GS} = 10V$  | 5.5A                            |
|               | 55m $\Omega$ @ $V_{GS} = 4.5V$ | 4.7A                            |

**Features and Benefits**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **Qualified to AEC-Q101 standards for High Reliability**

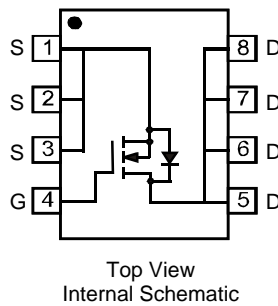
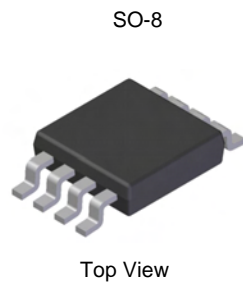
**Description and Applications**

This MOSFET has been designed to minimize the on-state resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- Power Management Functions
- DC-DC Converters

**Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish — Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 **e3**
- Weight: 0.008 grams (approximate)

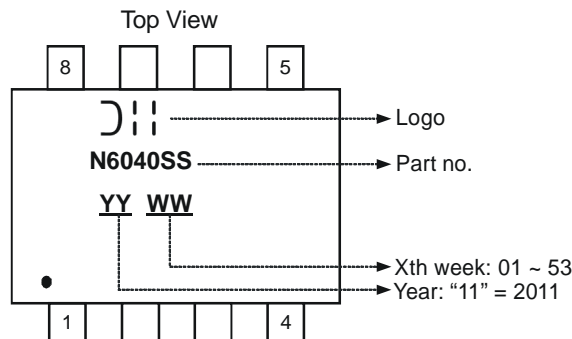


**Ordering Information** (Note 4)

| Part Number   | Case | Packaging        |
|---------------|------|------------------|
| DMN6040SSS-13 | SO-8 | 2500/Tape & Reel |

- Notes:
1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
  2. See <http://www.diodes.com> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
  3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
  4. For packaging details, go to our website at <http://www.diodes.com>.

**Marking Information**



**Maximum Ratings** @T<sub>A</sub> = 25°C unless otherwise specified

| Characteristic  | Symbol           | Value                 | Units |
|---|------------------|-----------------------|-------|
| Drain-Source Voltage                                    | V <sub>DSS</sub> | 60                    | V     |
| Gate-Source Voltage                                     | V <sub>GSS</sub> | ±20                   | V     |
| Continuous Drain Current (Note 6) V <sub>GS</sub> = 10V | I <sub>D</sub>   | T <sub>A</sub> = 25°C | 5.5   |
|   |                  | T <sub>A</sub> = 70°C | 4.4   |
|   | I <sub>D</sub>   | T <sub>A</sub> = 25°C | 7.0   |
|   |                  | T <sub>A</sub> = 70°C | 5.5   |
| Maximum Continuous Body Diode Forward Current (Note 6)  | I <sub>S</sub>   | 2.5                   | A     |
| Pulsed Drain Current (10μs pulse, duty cycle = 1%)      | I <sub>DM</sub>  | 30                    | A     |
| Avalanche Current (Note 7) L = 0.1mH                    | I <sub>AR</sub>  | 14.2                  | A     |
| Repetitive Avalanche Energy (Note 7) L = 0.1mH          | E <sub>AR</sub>  | 10                    | mJ    |

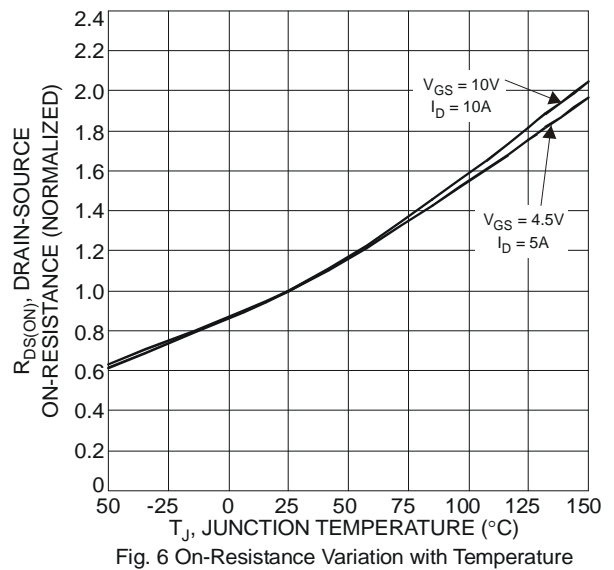
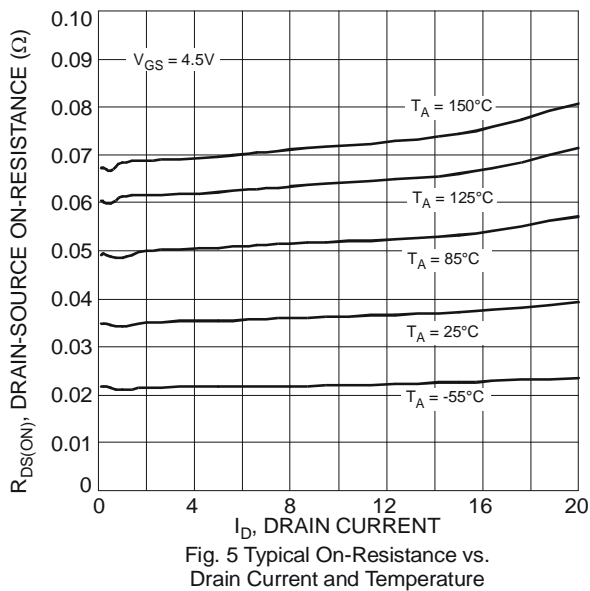
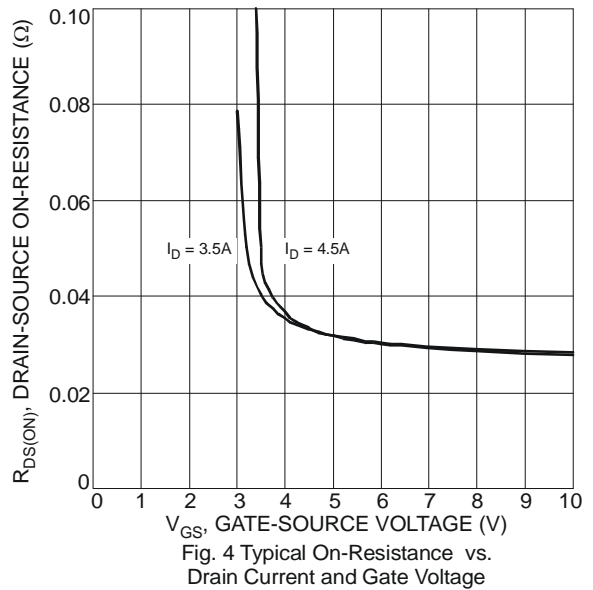
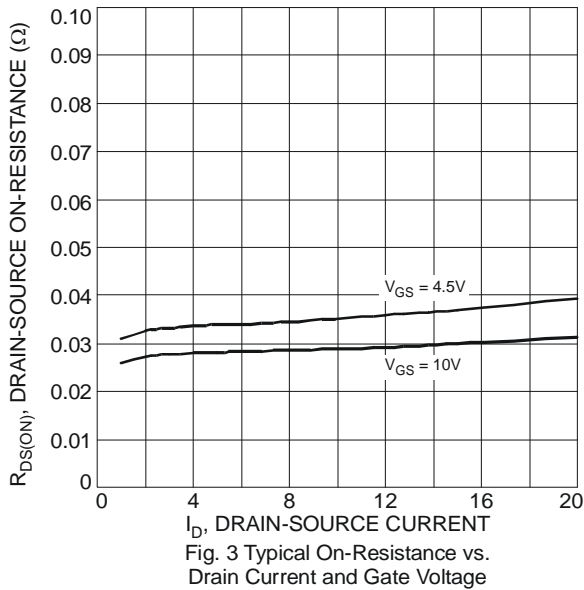
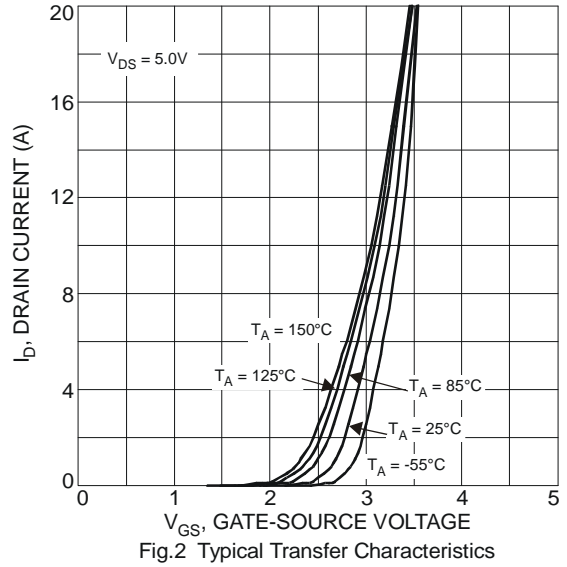
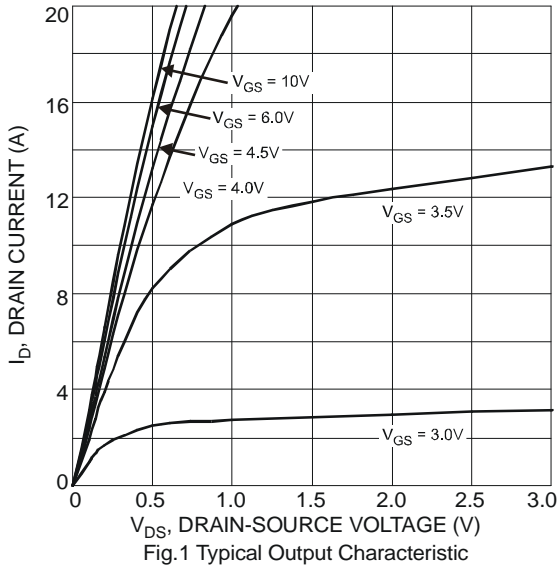
**Thermal Characteristics** @T<sub>A</sub> = 25°C unless otherwise specified

| Characteristic                                   | Symbol                            | Value                 | Units |
|--|-----------------------------------|-----------------------|-------|
| Total Power Dissipation (Note 5)                 | P <sub>D</sub>                    | T <sub>A</sub> = 25°C | 1.5   |
|  |                                   | T <sub>A</sub> = 70°C | 1     |
| Thermal Resistance, Junction to Ambient (Note 5) | R <sub>θJA</sub>                  | Steady State          | 80    |
|  |                                   | t < 10s               | 48    |
| Total Power Dissipation (Note 6)                 | P <sub>D</sub>                    | T <sub>A</sub> = 25°C | 2.0   |
|  |                                   | T <sub>A</sub> = 70°C | 1.3   |
| Thermal Resistance, Junction to Ambient (Note 6) | R <sub>θJA</sub>                  | Steady State          | 61    |
|  |                                   | t < 10s               | 37    |
| Thermal Resistance, Junction to Case             | R <sub>θJC</sub>                  | 6.4                   | °C/W  |
| Operating and Storage Temperature Range          | T <sub>J</sub> , T <sub>STG</sub> | -55 to 150            | °C    |

**Electrical Characteristics** T<sub>A</sub> = 25°C unless otherwise specified

| Characteristic                             | Symbol              | Min | Typ  | Max  | Unit | Test Condition  |
|--|---------------------|-----|------|------|------|---|
| <b>OFF CHARACTERISTICS (Note 8)</b>        |                     |     |      |      |      |   |
| Drain-Source Breakdown Voltage             | BV <sub>DSS</sub>   | 60  | —    | —    | V    | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA  |
| Zero Gate Voltage Drain Current            | I <sub>DSS</sub>    | —   | —    | 100  | nA   | V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V   |
| Gate-Source Leakage                        | I <sub>GSS</sub>    | —   | —    | ±100 | nA   | V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V  |
| <b>ON CHARACTERISTICS (Note 8)</b>         |                     |     |      |      |      |   |
| Gate Threshold Voltage                     | V <sub>GS(th)</sub> | 1   | —    | 3    | V    | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA                                  |
| Static Drain-Source On-Resistance          | R <sub>DS(on)</sub> | —   | 30   | 40   | mΩ   | V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.5A  |
|  |                     | —   | 35   | 55   |      | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.5A   |
| Forward Transfer Admittance                | Y <sub>fs</sub>     | —   | 4.5  | —    | S    | V <sub>DS</sub> = 10V, I <sub>D</sub> = 4.3A  |
| Diode Forward Voltage                      | V <sub>SD</sub>     | —   | 0.7  | 1.2  | V    | V <sub>GS</sub> = 0V, I <sub>S</sub> = 1A   |
| <b>DYNAMIC CHARACTERISTICS (Note 9)</b>    |                     |     |      |      |      |   |
| Input Capacitance                          | C <sub>iss</sub>    | —   | 1287 | —    | pF   | V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V<br>f = 1.0MHz                                   |
| Output Capacitance                         | C <sub>oss</sub>    | —   | 57   | —    |      |   |
| Reverse Transfer Capacitance               | C <sub>rss</sub>    | —   | 44   | —    |      |   |
| Gate Resistance                            | R <sub>G</sub>      | —   | 1.2  | —    | Ω    | V <sub>DS</sub> = 0V, V <sub>GS</sub> = 0V, f = 1.0MHz                                      |
| Total Gate Charge (V <sub>GS</sub> = 10V)  | Q <sub>g</sub>      | —   | 22.4 | —    | nC   | V <sub>DS</sub> = 30V, I <sub>D</sub> = 4.3A  |
| Total Gate Charge (V <sub>GS</sub> = 4.5V) | Q <sub>g</sub>      | —   | 10.4 | —    |      |   |
| Gate-Source Charge                         | Q <sub>gs</sub>     | —   | 4.9  | —    |      |   |
| Gate-Drain Charge                          | Q <sub>gd</sub>     | —   | 3.0  | —    |      |   |
| Turn-On Delay Time                         | t <sub>D(on)</sub>  | —   | 6.6  | —    | nS   | V <sub>GS</sub> = 10V, V <sub>DD</sub> = 30V, R <sub>G</sub> = 6Ω,<br>I <sub>D</sub> = 4.3A |
| Turn-On Rise Time                          | t <sub>r</sub>      | —   | 8.1  | —    |      |   |
| Turn-Off Delay Time                        | t <sub>D(off)</sub> | —   | 20.1 | —    |      |   |
| Turn-Off Fall Time                         | t <sub>f</sub>      | —   | 4.0  | —    |      |   |
| Body Diode Reverse Recovery Time           | t <sub>rr</sub>     | —   | 18   | —    | nS   | I <sub>S</sub> = 4.3A, dI/dt = 100A/μs  |
| Body Diode Reverse Recovery Charge         | Q <sub>rr</sub>     | —   | 11.9 | —    | nC   | I <sub>S</sub> = 4.3A, dI/dt = 100A/μs  |

- Notes:
- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
  - Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
  - I<sub>AR</sub> and E<sub>AR</sub> rating are based on low frequency and duty cycles to keep T<sub>J</sub> = 25°C
  - Short duration pulse test used to minimize self-heating effect.
  - Guaranteed by design. Not subject to product testing.



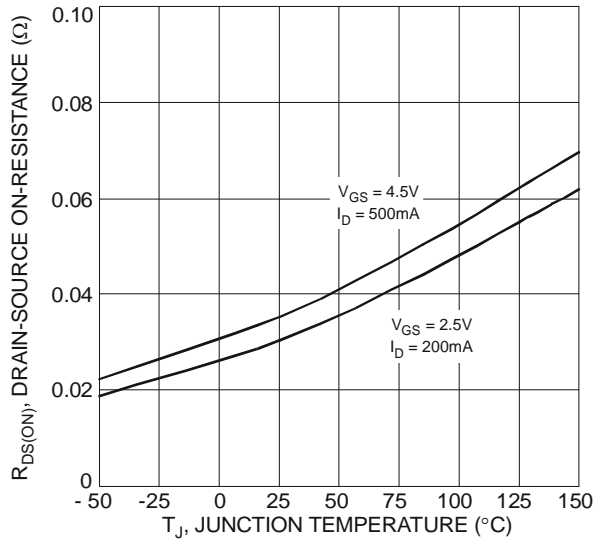


Fig. 7 On-Resistance Variation with Temperature

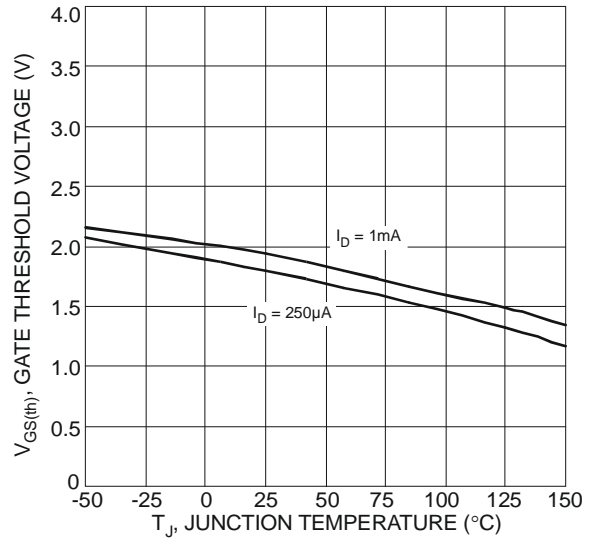


Fig. 8 Gate Threshold Variation vs. Ambient Temperature

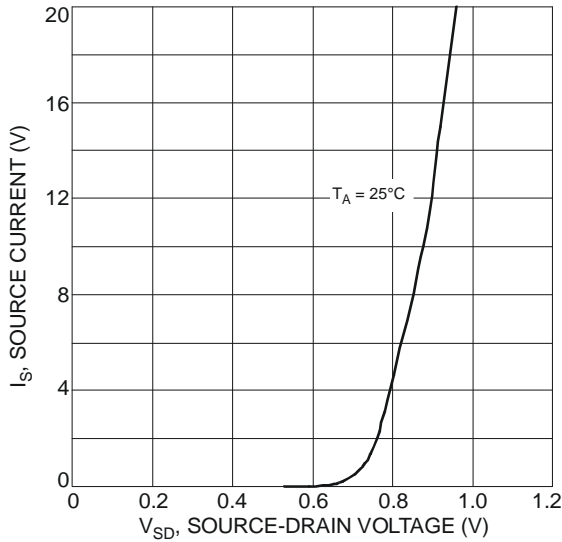


Fig.9 Diode Forward Voltage vs. Current

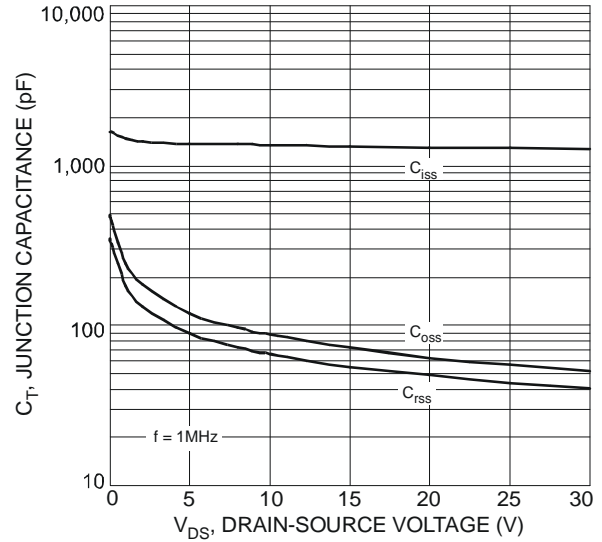


Fig. 10 Typical Junction Capacitance

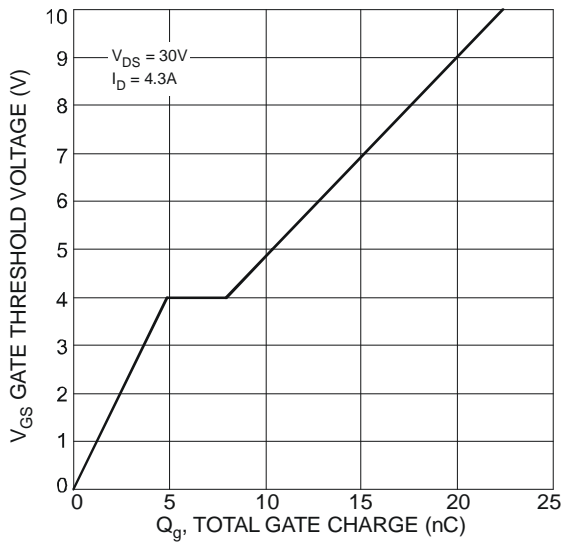
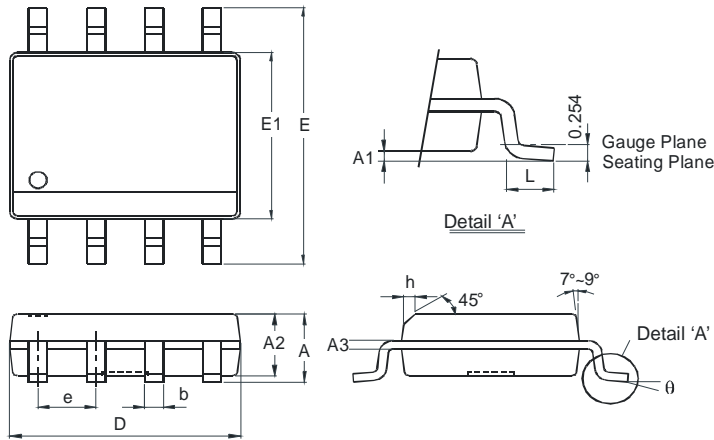


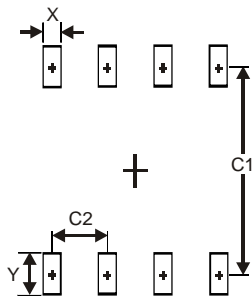
Fig. 11 Gate Charge

**Package Outline Dimensions**



| SO-8                 |          |      |
|----------------------|----------|------|
| Dim                  | Min      | Max  |
| A                    | -        | 1.75 |
| A1                   | 0.10     | 0.20 |
| A2                   | 1.30     | 1.50 |
| A3                   | 0.15     | 0.25 |
| b                    | 0.3      | 0.5  |
| D                    | 4.85     | 4.95 |
| E                    | 5.90     | 6.10 |
| E1                   | 3.85     | 3.95 |
| e                    | 1.27 Typ |      |
| h                    | -        | 0.35 |
| L                    | 0.62     | 0.82 |
| θ                    | 0°       | 8°   |
| All Dimensions in mm |          |      |

**Suggested Pad Layout**



| Dimensions | Value (in mm) |
|------------|---------------|
| X          | 0.60          |
| Y          | 1.55          |
| C1         | 5.4           |
| C2         | 1.27          |

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